

Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35511 D

T-29-01

PRO ELECTRON SERIES (Bipolar—see page 5-37 for JFET)



Type No.	Case Style	V _{CE} [*] V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CS} [*] I _{CB0} (mA) Max	V _{CB} (V)	HFE h _{FE} 1 kHz Min	HFE h _{FE} 1 kHz Max	I _C & V _{CE} (mA) & (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} (V) Min	V _{BE(ON)} (V) Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC107	TO-18	50	45	6	15*	50	40	125	0.01 5 500* 2 5	0.6 0.2		0.55 0.7*	100	4.5	150	10			1	04
BC107A	TO-18	50	45	6	15*	50	125	260*	0.01 5 500* 2 5	0.6 0.2		0.55 0.7*	100	4.5	150	10			1	04
BC107B	TO-18	50	45	6	15*	50	40	500*	0.01 5 500* 2 5	0.6 0.2		0.55 0.7*	100	4.5	150	10			1	04
BC108	TO-18	30	20	5	15*	30	40	125	0.01 5 900* 2 5	0.6 0.2		0.55 0.7*	100	4.5	150	10			1	04
BC108A	TO-18	30	20	5	15*	30	40	260*	0.01 5 500* 2 5	0.6 0.2		0.55 0.7*	100	4.5	150	10			1	04
BC108B	TO-18	30	20	5	15*	30	40	500*	0.01 5 500* 2 5	0.6 0.2		0.55 0.7*	100	4.5	150	10			1	04
BC108C	TO-18	30	20	5	15*	30	40	900*	0.01 5 500* 2 5	0.6 0.2		0.55 0.7*	100	4.5	150	10			1	04
BC109	TO-18	30	20	5	15*	30	100	240	0.01 5 900* 2 5	0.6 0.2		0.55 0.7*	100	4.5	150	10			1	04
BC109B	TO-18	30	20	5	15*	30	100	500*	0.01 5 500* 2 5	0.6 0.2		0.55 0.7*	100	4.5	150	10			1	04
BC109C	TO-18	30	20	5	15*	30	100	900*	0.01 5 500* 2 5	0.6 0.2		0.55 0.7*	100	4.5	150	10			1	04
BC140	TO-39	80*	40	7	100*	60	40	250	100* 1 100 100 1	1.0 1.0		1.8* 1.8*	1A	25	50	850			2	14
BC140-6	TO-39	80*	40	7	100*	60	40	160	100 1 100 100 1	1.0 1.0		1.8* 1.8*	1A	25	50	850			2	14
BC140-10	TO-39	80*	40	7	100*	60	63	250	100 1 100 100 1	1.0 1.0		1.8* 1.8*	1A	25	50	850			2	14
BC140-16	TO-39	80*	40	7	100*	60	100	450	100 1 100 100 1	1.0 1.0		1.8* 1.8*	1A	25	50	850			2	14
BC141	TO-39	100*	60	7	100*	60	40	250	100 1 100 100 1	1.0 1.0		1.8* 1.8*	1A	25	50	850			2	14
BC141-6	TO-39	100*	60	7	100*	60	40	100	100 1 100 100 1	1.0 1.0		1.8* 1.8*	1A	25	50	850			2	14
BC141-10	TO-39	100*	60	7	100*	60	63	160	100 1 100 100 1	1.0 1.0		1.8* 1.8*	1A	25	50	850			2	14

6501130 NATL SEMICOND, (DISCRETE)

28C 35512

D



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE0} [*] (V) Min	V _{CE0} [*] (V) Max	V _{BE0} (V) Min	V _{BE0} (V) Max	I _{CB0} [*] (mA) Max	V _{CB} (V) Max	HFE		I _C & V _{CE}		V _{CE(SAT)} & V _{BE(ON)} [*]		I _C		C _{ob} (pF) Max	f _T		t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.	
								Min	Max	Min	Max	Min	Max	Min	Max		Min	Max					Min
BC143	TO-5	60	60	5	40	50	40	20	200	2	1.5	1.5	500	200	20	60	50					63	
BC146-1	TO-92 (94)	20	20	4	40	50	40	80	200	2	1.5	1.5	500	200	20	60	50					04	
BC146-2	TO-92 (94)	20	20	4	40	50	40	140	350	2	1.5	1.5	500	200	20	60	50					04	
BC146-3	TO-92 (94)	20	20	4	40	50	40	280	550	2	1.5	1.5	500	200	20	60	50					04	
BC160	TO-39	40*	5	40	40	100	40	40	250	100	1.0	1.7*	1A	30	30	50	50	650				2	67
BC160-6	TO-39	40*	5	40	40	100	40	40	100	100	1.0	1.7*	1A	30	30	50	50	650				2	67
BC160-10	TO-39	40*	5	40	40	100	40	63	160	100	1.0	1.7*	1A	30	30	50	50	650				2	67
BC160-16	TO-39	40*	5	40	40	100	40	100	250	100	1.0	1.7*	1A	30	30	50	50	650				2	67
BC161	TO-39	60*	5	60	60	100	60	40	250	100	1.0	1.7*	1A	30	30	50	50	650				2	67
BC161-6	TO-39	60*	5	60	60	100	60	40	100	100	1.0	1.7*	1A	30	30	50	50	650				2	67
BC161-10	TO-39	60*	5	60	60	100	60	63	160	100	1.0	1.7*	1A	30	30	50	50	650				2	67
BC161-16	TO-39	60*	5	60	60	100	60	100	250	100	1.0	1.7*	1A	30	30	50	50	650				2	67
BC167	TO-92 (94)	60*	45	6	50	15*	50	110	500*	2	0.2	0.6	10	100	4.5	150	10				10	1	04
BC167A	TO-92 (94)	60*	45	6	50	15*	50	110	260*	2	0.2	0.6	10	100	4.5	150	10				10	1	04
BC167B	TO-92 (94)	60*	45	6	50	15*	50	110	500*	2	0.2	0.6	10	100	4.5	150	10				10	1	04
BC168	TO-92 (94)	60*	20	5	30	15*	30	110	900*	2	0.2	0.6	10	100	4.5	150	10				10	1	04
BC168A	TO-92 (94)	60*	20	5	30	15*	30	110	260*	2	0.2	0.6	10	100	4.5	150	10				10	1	04
BC168B	TO-92 (94)	60*	20	5	30	15*	30	110	500*	2	0.2	0.6	10	100	4.5	150	10				10	1	04

T-29-01

TEST CONDITIONS:
 (1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 μA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

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Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35513 D

T-29-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} * V _{CB0} (V) Min	V _{CEO} (V) Min	V _{EB0} (V) Min	I _{CS} * I _{CB0} (mA) Max	H _{FE} h _{FE} 1 kHz* Min Max	I _C & V _{CE} (mA) & (V) Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)*} (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz)		I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
												Min	Max					
BC168C	TO-92 (94)		20	5	15*	110 450	2 900*	5 5	0.2 0.6	10 100	4.5	150	10	10		1	04	
BC169	TO-92 (94)		20	5	15*	110 240	2 900*	5 5	0.2 0.6	10 100	4.5	150	10	4		1	04	
BC169B	TO-92 (94)		20	5	15*	110 240	2 500*	5 5	0.2 0.6	10 100	4.5	150	10	4		1	04	
BC169C	TO-92 (94)		20	5	15*	110 450	2 900*	5 5	0.2 0.6	10 100	4.5	150	10	4		1	04	
BC177	TO-18	50	45	5	100	110 125	2 500*	5 5	0.18	10 75*	4.5	150	10	10		1	71	
BC177A	TO-18	50	45	5	100	110 125	2 260*	5 5	0.18	10 75*	4.5	150	10	10		1	71	
BC177B	TO-18	50	45	5	100	110 240	2 500*	5 5	0.18	10 75*	4.5	150	10	10		1	71	
BC177VI	TO-18	50	45	5	100	110 75	2 150*	5 5	0.18	10 75*	4.5	150	10	10		1	71	
BC178	TO-18	30	25	5	100	110 125	2 900*	5 5	0.18	10 75*	4.5	150	10	10		1	71	
BC178A	TO-18	30	25	5	100	110 125	2 260*	5 5	0.18	10 75*	4.5	150	10	10		1	71	
BC178B	TO-18	30	25	5	100	110 240	2 500*	5 5	0.18	10 75*	4.5	150	10	10		1	71	
BC179	TO-18	25	20	5	100	110 125	2 900*	5 5	0.18	10 75*	4.5	150	10	4		1	71	
BC179A	TO-18	25	20	5	100	110 125	2 260*	5 5	0.18	10 75*	4.5	150	10	4		1	71	

6501130 NATL SEMICOND, (DISCRETE)

28C 35514

T-29-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} * V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CB0} * (mA) Max	HFE h _{FE} 1 kHz* Min Max	I _C & V _{CE} (mA) & (V) Min Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)*} (V) Min Max	I _C (mA) Min Max	C _{ob} (pF) Max	f _T (MHz) Min Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC179B	TO-18	25	20	5	100	110 240	2 5 500* 2 5	0.18	0.75 1.0*	10	4.5	150		4	1	71
BC182	TO-92 (97)	60	50	5	15	40 80 125	0.01 5 100 5 500* 2 5	0.6 0.25	1.2 0.70*	10	5	150		10	1	04
BC182A	TO-92 (97)	60	50	5	15	40 80 125	0.01 5 100 5 260* 2 5	0.6 0.25	1.2 0.70*	10	5	150		10	1	04
BC182B	TO-92 (97)	60	50	5	15	40 80 240	0.01 5 100 5 500* 2 5	0.6 0.25	1.2 0.70*	10	5	150		10	1	04
BC182L	TO-92 (94)	60	50	5	15	40 80 125	0.01 5 100 5 500* 2 5	0.6 0.25	1.2 0.70*	10	5	150		10	1	04
BC182LA	TO-92 (94)	60	50	5	15	40 80 125	0.01 5 100 5 260* 2 5	0.6 0.25	1.2 0.70*	10	5	150		10	1	04
BC182LB	TO-92 (94)	60	50	5	15	40 80 240	0.01 5 100 5 500* 2 5	0.6 0.25	1.2 0.70*	10	5	150		10	1	04
BC183	TO-92 (97)	45	30	5	15	40 80 125	0.01 5 100 5 900* 2 5	0.6 0.25	1.2 0.70*	10	5	150		10	1	04
BC183A	TO-92 (97)	45	30	5	15	40 80 125	0.01 5 100 5 260* 2 5	0.6 0.25	1.2 0.70*	10	5	150		10	1	04
BC183B	TO-92 (97)*	45	30	5	15	40 80 240	0.01 5 100 5 500* 2 5	0.6 0.25	1.2 0.70*	10	5	150		10	1	04
BC183C	TO-92 (97)	45	30	5	15	40 80 450	0.01 5 100 5 900* 2 5	0.6 0.25	1.2 0.70*	10	5	150		10	1	04

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B = I_C = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B = I_C = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B = I_C = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B = I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

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6501130 NATL SEMICOND, (DISCRETE)

28C 35515 D

Pro Electron Series

T-29-01

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE} [*] V _{CB} (V) Min	V _{CE} [*] V _{CB} (V) Max	V _{EB} (V) Min	V _{EB} (V) Max	I _{CB} [*] I _{CB} (mA) Max	HFE h _{FE} @ 1 kHz Min	HFE h _{FE} @ 1 kHz Max	I _C & V _{CE} (mA) (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} (V) Min	V _{BE(ON)} [*] (V) Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC183L	TO-92 (94)	45	30	5	15	30	40	125	0.01 100	0.6 0.25	1.2 0.70*	100	5	150	10			1	04	
BC183LA	TO-92 (94)	45	30	5	15	30	40	80	0.01 100	0.6 0.25	1.2 0.70*	100	5	150	10			1	04	
BC183LB	TO-92 (94)	45	30	5	15	30	40	125	0.01 100	0.6 0.25	1.2 0.70*	100	5	150	10			1	04	
BC183LC	TO-92 (94)	45	30	5	15	30	40	240	0.01 100	0.6 0.25	1.2 0.70*	100	5	150	10			1	04	
BC184	TO-92 (97)	45	30	5	15	30	100	450	0.01 100	0.6 0.25	1.2 0.70*	100	5	150	10			1	04	
BC184B	TO-92 (97)	45	30	5	15	30	130	240	0.01 100	0.6 0.25	1.2 0.70*	100	5	150	10			1	04	
BC184C	TO-92 (97)	45	30	50	15	30	100	450	0.01 100	0.6 0.25	1.2 0.70*	100	5	150	10			1	04	
BC184L	TO-92 (94)	45	30	50	15	30	130	240	0.01 100	0.6 0.25	1.2 0.70*	100	5	150	10			1	04	
BC184LB	TO-92 (94)	45	30	50	15	30	100	240	0.01 100	0.6 0.25	1.2 0.70*	100	5	150	10			1	04	
BC184LC	TO-92 (94)	45	30	50	15	30	100	450	0.01 100	0.6 0.25	1.2 0.70*	100	5	150	10			1	04	
BC204	TO-92 (92)	50	45	5	50	45	50	450	2	0.3		10						1	71	
BC207	TO-92 (92)	50	45	5	15	40	110	450	2	0.25 0.6		100	6					1	04	
BC212	TO-92 (97)	60	50	5	15	30	60	400*	2	0.6 0.25	1.1 0.6	100 0.72*	10 2	200	10			1	63	

6501130 NATL SEMICOND, (DISCRETE)

28C 35516

T-29-01



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB} (V) Min	V _{CE} (V) Min	V _{EB} (V) Min	I _{CB} (mA) Max	HFE h _{FE} 1 kHz* Min	I _C & V _{CE} (mA) & (V) Max	V _{CE} (SAT) (V) Max	V _{BE} (SAT) & V _{BE} (ON)* (V) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC212A	TO-92 (97)	60	50	5	15	100	0.01 5	0.6 0.25	1.1 0.72*	100 10	10	200	10		10	1	63
BC212B	TO-92 (97)	60	50	5	15	200	0.01 5	0.6 0.25	1.1 0.72*	100 10	10	200	10		10	1	63
BC212L	TO-92 (94)	60	50	5	15	40 60 80	0.01 5	0.6 0.25	1.1 0.72*	100 10	10	200	10		10	1	63
BC212LA	TO-92 (94)	60	50	5	15	100	0.01 5	0.6 0.25	1.1 0.72*	100 10	10	200	10		10	1	63
BC212LB	TO-92 (94)	60	50	5	15	200	0.01 5	0.6 0.25	1.1 0.72*	100 10	10	200	10		10	1	63
BC213	TO-92 (97)	45	30	5	15	40 60 80	0.01 5	0.6 0.25	1.1 0.72*	100 10	10	200	10		10	1	63
BC213A	TO-92 (97)	45	30	5	15	100	0.01 5	0.6 0.25	1.1 0.72*	100 10	10	200	10		10	1	63
BC213B	TO-92 (97)	45	30	5	15	200	0.01 5	0.6 0.25	1.1 0.72*	100 10	10	200	10		10	1	63
BC213C	TO-92 (97)	45	30	5	15	350	0.01 5	0.6 0.25	1.1 0.72*	100 10	10	200	10		10	1	63
BC213L	TO-92 (94)	45	30	5	15	40 80	0.01 5	0.6 0.25	1.1 0.72*	100 10	10	200	10		10	1	63
BC213LA	TO-92 (94)	45	30	5	15	100	0.01 5	0.6 0.25	1.1 0.72*	100 10	10	200	10		10	1	63

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

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Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35517 D

T-29-01



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CB0} [*] (mA) Max	I _{CB0} (mA) Max	HFE h _{FE} 1 kHz [*] Min	HFE h _{FE} 1 kHz [*] Max	I _C & V _{CE} (mA) (V) Min	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC213LB	TO-92 (94)	45	30	5	15	30	40	80	0.01	0.6	1.1	100	10	200	10		10	1	63
BC213LC	TO-92 (94)	45	30	5	15	30	200	400*	0.01	0.25	0.6	10	10	200	10		10	1	63
BC214	TO-92 (97)	45	30	5	15	30	80	350	0.01	0.6	1.1	100	10	200	10		2	1	63
BC214A	TO-92 (97)	45	30	5	15	30	80	140	0.01	0.6	1.1	100	10	200	10		2	1	63
BC214B	TO-92 (97)	45	30	5	15	30	40	80	0.01	0.6	1.1	100	10	200	10		2	1	63
BC214C	TO-92 (97)	45	30	5	15	30	200	400*	0.01	0.6	1.1	100	10	200	10		2	1	63
BC214L	TO-92 (94)	45	30	5	15	30	80	350	0.01	0.6	1.1	100	10	200	10		2	1	63
BC214LB	TO-92 (94)	45	30	5	15	30	100	140	0.01	0.6	1.1	100	10	200	10		2	1	63
BC214LC	TO-92 (94)	45	30	5	15	30	120	200	0.01	0.6	1.1	100	10	200	10		2	1	63
BC237-92	TO-92 (97)	50	45	6	50	20	100	140	0.01	0.25	0.77*	10	4.5				10	1	04
BC237A-92	TO-92 (97)	50	45	6	50	20	125	500*	0.01	0.25	0.55	10	4.5				10	1	04

6501130 NATL SEMICOND, (DISCRETE)

28C 35518
T-24-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CE} [*] I _{CB0} (mA) Max	HFE h _{FE} 1 kHz [*] Min	I _C & V _{CE} @ (mA) & (V) Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC237B-92	TO-92 (97)	50	45	6	50	100	0.01 5 2 5 100 5 500* 2 5	0.25	0.77* 10 0.6 100	10	4.5				10	1	04
BC238-92	TO-92 (97)	30	20	5	50	100	0.01 5 2 5 100 5 500* 2 5	0.25	0.77* 10 0.6 100	10	4.5				10	1	04
BC238A-92	TO-92 (97)	30	20	5	50	100	0.01 5 2 5 100 5 500* 2 5	0.25	0.77* 10 0.6 100	10	4.5				10	1	04
BC238B-92	TO-92 (97)	30	20	5	50	100	0.01 5 2 5 100 5 500* 2 5	0.25	0.77* 10 0.6 100	10	4.5				10	1	04
BC238C-92	TO-92 (97)	30	20	5	50	100	0.01 5 2 5 100 5 500* 2 5	0.25	0.77* 10 0.6 100	10	4.5				10	1	04
BC239-92	TO-92 (97)	30	20	5	50	100	0.01 5 2 5 100 5 500* 2 5	0.25	0.77* 10 0.6 100	10	4.5				4	1	04
BC239B-92	TO-92 (97)	30	20	5	50	100	0.01 5 2 5 100 5 500* 2 5	0.25	0.77* 10 0.6 100	10	4.5				4	1	04
BC239C-92	TO-92 (97)	30	20	5	50	100	0.01 5 2 5 100 5 500* 2 5	0.25	0.77* 10 0.6 100	10	4.5				4	1	04
BC261A	TO-18		45		50	100	0.01 5 2 5 100 5 500* 2 5	0.25	0.9 10 0.6 100	6	4.5				6	3	71

TEST CONDITIONS:
 (1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 μA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

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Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35519 D

T-29-01



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB} (V) Min	V _{CE} (V) Min	V _{EB} (V) Min	I _{CE} [*] I _{CB} (mA) Max	HFE h _{FE} 1 kHz Min	I _C & V _{CE} (mA) & (V) Max	V _{CE} (SAT) (V) Max	V _{BE} (SAT) & V _{BE} (ON) [*] (V) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC261B	TO-18		45		50	100	0.01 5	0.25	0.9	10					6	3	71
BC262A	TO-18		20	5	50	100	0.01 5	0.25	0.9	10					6	3	71
BC262B	TO-18		20	5	50	100	0.01 5	0.25	0.9	10					6	3	71
BC263A	TO-18		20	5	50	100	0.01 5	0.25	0.9	10					2.5	3	71
BC263B	TO-18		20	5	50	100	0.01 5	0.25	0.9	10					2.5	3	71
BC307-92	TO-92 (97)	50	45	5	100	100	0.01 5	0.18	0.78	10					10	1	71
BC307A-92	TO-92 (97)	50	45	5	100	100	0.01 5	0.18	0.78	10					10	1	71
BC307B-92	TO-92 (97)	50	45	5	100	100	0.01 5	0.18	0.78	10					10	1	71
BC308-92	TO-92 (97)	30	25	5	100	100	0.01 5	0.18	0.78	10					10	1	71
BC308A-92	TO-92 (97)	30	25	5	100	100	0.01 5	0.18	0.78	10					10	1	71

6501130 NATL SEMICOND, (DISCRETE)

28C 35520

T-29-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	VCES* VCBO (V) Min	VCEO (V) Min	VEBO (V) Min	ICES* ICBO @ VCB (nA) Max	HFE hfe @ 1 kHz*		VCE(SAT) (V) Max		VBE(SAT) & VBE(ON)* (V) Min Max		IC (mA) Max	Cob (pF) Max	fT (MHz) Min Max	IC (mA) Max	toff (ns) Max	NF (dB) Max	Test Conditions	Process No.
						Min	Max	Min	Max	Min	Max								
BC308B-92	TO-92 (97)	30	25	5	100	100	0.01	5	0.18	0.78	10	10						71	
BC308C-92	TO-92 (97)	30	25	5	100	140	400	5	0.18	0.78	10	100						71	
BC309-92	TO-92 (97)	25	20	5	100	140	400	5	0.18	0.78	10	100						71	
BC309B-92	TO-92 (97)	25	20	5	100	120	900*	5	0.18	0.75	2	100						71	
BC309C-92	TO-92 (97)	25	20	5	100	120	500*	5	0.8	0.78	10	100						71	
BC317	TO-92 (92)	50	45	6	30	100	450	5	0.2	0.77*	10	100	4					04	
BC317A	TO-92 (92)	50	45	6	30	110	220	5	0.2	0.77*	10	100	4					04	
BC317B	TO-92 (92)	50	45	6	30	200	450	5	0.2	0.77*	10	100	4					04	
BC318	TO-92 (92)	30	20	5	30	110	800	5	0.2	0.77*	10	100	4					04	
BC318A	TO-92 (92)	30	20	5	30	125	900*	5	0.2	0.77*	10	100	4					04	

TEST CONDITIONS:
 (1) IC = 200 μA, VCE = 5V, f = 1 kHz. (2) IC = 100 mA, VCC = 20V, IB¹ = IB² = 5 mA. (3) IC = 200 μA, VCE = 2V, f = 1 kHz. (4) IC = 100 mA, VCC = 10V, IB¹ = IB² = 10 mA. (5) IC = 10 mA, VCC = 3V, IB¹ = IB² = 1 mA. (6) IC = 100 μA, VCE = 5V, f = 1 kHz. (7) IC = 1 mA, VCE = 10V, f = 200 kHz. (8) IC = 1 mA, VCE = 5V, f = 1 kHz. (9) IC = 150 mA, VCC = 6V, IB¹ = IB² = 15 mA. (10) IC = 10 μA, VCE = 5V, f = WB.

Pro Electron Series

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6501130 NATL SEMICOND, (DISCRETE)

28C 35521 D

T-29-01

Pro Electron Series

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE0} [*] (V)		V _{BE0} (V)	I _{CS0} [*] (mA)		h _{FE} @ 1 kHz		I _C & V _{CE}		V _{CE(SAT)} & V _{BE(ON)} [*]		V _{BE(SAT)} & V _{BE(ON)} [*]		C _{ob} (pF)	f _T (MHz)		I _C (mA)	t _{off} (ns)	NF (dB) Max	Test Conditions	Process No.	
		Min	Max		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max		Min	Max						
BC318B	TO-92 (92)	30	20	5	30	20	200	450	2	5	0.2	0.5	0.77*	10	4						6	1	04
BC318C	TO-92 (92)	30	20	5	30	20	100	450	0.01	5	0.2	0.5	0.77*	10	4						6	1	04
BC319	TO-92 (92)	30	20	5	30	20	40	200	0.01	5	0.2	0.5	0.77*	10	4						4	1	04
BC319B	TO-92 (92)	30	20	5	30	20	200	450	0.01	5	0.2	0.5	0.77*	10	4						4	1	04
BC319C	TO-92 (92)	30	20	5	30	20	100	420	0.01	5	0.2	0.5	0.77*	10	4						4	1	04
BC327	TO-92 (97)	50†	45	5	100†	45	40	100	300	1	0.7			500	4						4	1	67
BC327-10	TO-92 (97)	50†	45	5	100†	45	40	160	300	1	0.7			500	4						4	1	67
BC327-16	TO-92 (97)	50†	45	5	100†	45	40	100	300	1	0.7			500	4						4	1	67
BC327-25	TO-92 (97)	50†	45	5	100†	45	40	160	300	1	0.7			500	4						4	1	67
BC328	TO-92 (97)	30†	25	5	100†	25	40	100	300	1	0.7			500	4						4	1	67
BC328-10	TO-92 (97)	30†	25	5	100†	25	40	160	300	1	0.7			500	4						4	1	67
BC328-16	TO-92 (97)	30†	25	5	100†	25	40	100	300	1	0.7			500	4						4	1	67
BC328-25	TO-92 (97)	30†	25	5	100†	25	40	160	300	1	0.7			500	4						4	1	67
BC337	TO-92 (97)	50†	45	5	100†	45	40	100	300	1	0.7			500	4						4	1	14
BC337-10	TO-92 (97)	50†	45	5	100†	45	40	160	300	1	0.7			500	4						4	1	14
BC337-16	TO-92 (97)	50†	45	5	100†	45	40	100	300	1	0.7			500	4						4	1	14
BC337-25	TO-92 (97)	50†	45	5	100†	45	40	160	300	1	0.7			500	4						4	1	14

6501130 NATL SEMICOND, (DISCRETE)

28C 35522

T-29-01



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE0} [*] (V) Min	V _{CE0} [*] (V) Max	V _{BO} [*] (V) Min	V _{BO} [*] (V) Max	I _{CB0} [*] (mA) Max	V _{CB} (V)	HFE h _{FE} 1 kHz [*] Min Max	I _C & V _{CE} (mA) (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} (V) Min	I _C (mA) Min Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC338	TO-92 (97)	25	30†	5	100†	25	25	40 100 600	300 100 1	0.7	1.2*	500 300	4				4	1	14
BC338-10	TO-92 (97)	25	30†	5	100†	25	25	40 63 160	300 100 1	0.7	1.2*	500 300	4				4	1	14
BC338-16	TO-92 (97)	25	30†	5	100†	25	25	100 250	300 100 1	0.7	1.2*	500 300	4				4	1	14
BC338-25	TO-92 (97)	25	30†	5	100†	25	25	40 160 400	300 100 1	0.7	1.2*	500 300	4				4	1	14
BC415	TO-92 (97)	45	45	5	15	30	30	40 120 800	0.01 2 5	0.25 0.6		10					2	10	71
BC415A	TO-92 (97)	45	45	5	15	30	30	40 120 220	0.01 2 5	0.25 0.6		10					2	10	71
BC415B	TO-92 (97)	45	45	5	15	30	30	100 180 460	0.01 2 5	0.25 0.6		10					2	10	71
BC415C	TO-92 (97)	45	45	5	15	30	30	100 380 800	0.01 2 5	0.25 0.6		10					2	10	71
BC485	TO-92 (97)	45	45	5	100	30	30	15 40 60	1A 10 100	0.5	1.2*	500 300	4				4	1	14
BC485A	TO-92 (97)	45	45	5	100	30	30	15 40 100	1A 10 2	0.5	1.2*	500 300	4				4	1	14
BC485B	TO-92 (97)	45	45	5	100	30	30	15 40 160	1A 10 100	0.5	1.2*	500 300	4				4	1	14
BC485L	TO-92 (97)	45	45	5	100	30	30	15 40 60	1A 10 100	0.5	1.2*	500 300	4				4	1	14
BC547	TO-92 (97)	50	50	6	10	20	20	125	500* 2	0.25 0.6	0.77* 10	100	4.5				10	1	04
BC547A	TO-92 (97)	50	50	6	10	20	20	125	260* 2	0.25 0.6	0.77* 10	100	4.5				10	1	04

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CC} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CC} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CC} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CC} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

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Pro Electron Series

Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35523 D

T-29-01



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	VCES* VCBO (V) Min	VCEO (V) Min	VEBO (V) Min	ICES* ICBO (mA) Max	HFE h _{FE} @ 1 kHz* Min Max	VCE(SAT) (V) Max	VBE(SAT) & VBE(ON)* (V)		C _{ob} (pF) Max	f _T (MHz) Min Max	I _C @ (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
								Min	Max							
BC547B	TO-92 (97)	50	45	6	10	240	0.25 0.6	0.77* 0.55	10 100	4.5				10	1	04
BC547C	TO-92 (97)	50	45	6	10	450	0.25 0.6	0.77* 0.55	10 100	4.5				10	1	04
BC548	TO-92 (97)	30	20	5	10	125	0.25 0.6	0.77* 0.55	10 100	4.5				10	1	04
BC548A	TO-92 (97)	30	20	5	10	125	0.25 0.6	0.77* 0.55	10 100	4.5				10	1	04
BC548B	TO-92 (97)	30	20	5	10	240	0.25 0.6	0.77* 0.55	10 100	4.5				10	1	04
BC548C	TO-92 (97)	30	20	5	10	450	0.25 0.6	0.77* 0.55	10 100	4.5				10	1	04
BC549	TO-92 (97)	30	20	5	10	240	0.25 0.6	0.77* 0.55	10 100	4.5				4	1	04
BC549B	TO-92 (97)	30	20	5	10	450	0.25 0.6	0.77* 0.55	10 100	4.5				4	1	04
BC549C	TO-92 (97)	30	20	5	10	240	0.25 0.6	0.77* 0.55	10 100	4.5				4	1	04
BC550	TO-92 (97)	50	45	5	10	450	0.25 0.6	0.77* 0.55	10 100					3	1	04
BC550B	TO-92 (97)	50	45	5	10	240	0.25 0.6	0.77* 0.55	10 100					3	1	04
BC550C	TO-92 (97)	50	45	5	10	450	0.25 0.6	0.77* 0.55	10 100					3	1	04
BC557	TO-92 (97)	50	45	5	100	75	0.3 0.65	0.82* 0.6	10 100					10	1	71

6501130 NATL SEMICOND, (DISCRETE)

28C 35524

T-29-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB} (V) Min	V _{CE} [*] (V) Min	V _{BO} (V) Min	I _{CB} [*] I _{BO} (mA) Max	H _{FE} h _{FE} 1 kHz Min Max	I _C & V _{CE} (mA) & (V) Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC557A	TO-92 (97)	50	45	5	100	20	20	0.3 0.65	0.82* 0.75* 2	10 100					10	1	71
BC557B	TO-92 (97)	50	45	5	100	20	20	0.3 0.65	0.82* 0.6 0.75* 2	10 100					10	1	71
BC558	TO-92 (97)	30	25	5	100	20	20	0.3 0.65	0.82* 0.6 0.75 2	10 100					10	1	71
BC558A	TO-92 (97)	30	25	5	100	20	20	0.3 0.65	0.82* 0.6 0.75 2	10 100					10	1	71
BC558B	TO-92 (97)	30	25	5	100	20	20	0.3 0.65	0.82* 0.6 0.75 2	10 100					10	1	71
BC558C	TO-92 (97)	30	25	5	100	20	20	0.3 0.65	0.82* 0.6 0.75 2	10 100					10	1	71
BC559	TO-92 (97)	25	20	5	100	20	20	0.3 0.65	0.82* 0.6 0.75* 2	10 100					4	1	71
BC559A	TO-92 (97)	25	20	5	100	20	20	0.3 0.65	0.82* 0.6 0.75* 2	10 100					4	1	71
BC559B	TO-92 (97)	25	20	5	100	20	20	0.3 0.65	0.82* 0.6 0.75* 2	10 100					4	1	71
BC559C	TO-92 (97)	25	20	5	100	20	20	0.3 0.65	0.82* 0.6 0.75* 2	10 100					4	1	71
BC560	TO-92 (97)	50	45	5	100	45	45	0.3 0.65	0.82* 0.6 0.75* 2	10 100					2	1	71

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CC} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CC} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CC} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CC} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

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Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35525

D

T-29-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} * V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CE} * I _{CB0} @ (mA) Max	HFE h _{FE} 1 kHz* Min Max	I _C & V _{CE} (mA) & (V) Min Max	V _{CE(SAT)} & V _{BE(ON)*} (V) & (V) Min Max	I _C @ (mA) Min Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C @ (mA) Min Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC560A	TO-92 (97)	50	45	5	100	125 260*	2 5	0.3 0.65	0.82* 10					2	1	71
BC560B	TO-92 (97)	50	45	5	100	240 500*	2 5	0.3 0.65	0.82* 10					2	1	71
BC560C	TO-92 (97)	50	45	5	100	450 900*	2 5	0.3 0.65	0.82* 10					2	1	71
BCX58	TO-92 (97)		32	7	10	120 630	2 5				125	10	800	6	3/4	04
BCX58-7	TO-92 (97)		32	7	10	80 1000	1 1				125	10	800	6	3/4	04
BCX58-8	TO-92 (97)		32	7	10	120 220	2 5				125	10	800	6	3/4	04
BCX58-9	TO-92 (97)		32	7	10	40 100	1 1				125	10	800	6	3/4	04
BCX58-10	TO-92 (97)		32	7	10	20 310	2 5				125	10	800	6	3/4	04
BCX59	TO-92 (97)		45	7	10	180 310	2 5				125	10	800	6	3/4	04
BCX59-7	TO-92 (97)		45	7	10	120 400	1 1				125	10	800	6	3/4	04
BCX59-8	TO-92 (97)		45	7	10	45 100	1 1				125	10	800	6	3/4	04
BCX59-9	TO-92 (97)		45	7	10	250 460	2 5				125	10	800	6	3/4	04

6501130 NATL SEMICOND, (DISCRETE)

28C 35526

D



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB} (V) Min	V _{CE} (V) Min	V _{EB} (V) Min	I _{CB} [*] I _{BO} (mA) Max	HFE h _{FE} 1 kHz [*] Min Max	I _C & V _{CE} (mA) (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BCX59-10	TO-92 (97)		45	7		100 380 630 240 1000 60	0.01 5 2 5 10 1 100 1	0.5	1.0	100		125	800		5	04
BCX78	TO-92 (97)		32	5		120 630 80 1000 40	2 5 10 1 100 1	0.6	1.0	100						71
BCX78-7	TO-92 (97)		32	5		120 220 80 100 40	2 5 10 1 100 1	0.6	1.0	100						71
BCX78-8	TO-92 (97)		32	5		30 180 310 120 400 45	0.01 5 2 5 10 1 100 1	0.6	1.0	100						71
BCX78-9	TO-92 (97)		32	5		40 250 460 160 630 60	0.01 5 2 5 10 1 100 1	0.6	1.0	100						71
BCX78-10	TO-92 (97)		32	5		100 380 630 240 1000 60	0.01 5 2 5 10 1 100 1	0.6	1.0	100						71
BCX79	TO-92 (97)		45	5		80 1000 40 630	10 1 2 5	0.6	1.0	100						71
BCX79-7	TO-92 (97)		45	5		120 220	2 5	0.6	1.0	100						71
BCX79-8	TO-92 (97)		45	5		120 400 45 30 180 310	10 1 1 5 0.01 5 2 5	0.6	1.0	100						71
BCX79-9	TO-92 (97)		45	5		160 630 60 40 250 460	10 1 1 5 0.01 5 2 5	0.6	1.0	100						71

T-29-01

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CC} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CC} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CC} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CC} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

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Pro Electron Series

Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35527 D

T-29-01

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE} [*] VCBO (V) Min	V _{BE} (V) Min	I _{CE} [*] I _{CB} (mA) Max	HFE h _{FE} @ 1 kHz Min Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BCX79-10	TO-92 (97)	45	5		240 1000 10 1 60 100 1 100 0.01 5 380 630 2 5	0.6	1.0 100							71
BCY56	TO-18	45	5	100	40 10 5 100 450 2 5 125 500* 2 5 40 0.01 5	0.6	0.7* 2					5	1	04
BCY57	TO-18	25	5	100	200 10 5 200 800 2 5 240 900* 2 5 100 0.01 5	0.6	0.7* 2					5	1	04
BCY58	TO-18	32	7	10 [†]	40 100 1 80 1000 10 1 125 700* 2 5	0.35 0.7	0.85 10 1.2 100 0.7* 2		6	125	800	6	4/1	04
BCY58-7	TO-18	32	7	10 [†]	40 100 1 80 1000 10 1 125 250* 2 5	0.35 0.7	0.85 10 1.2 100 0.7* 2		6	125	800	6	4/1	04
BCY58-8	TO-18	32	7	10 [†]	40 100 1 80 1000 10 1 175 350* 2 5	0.35 0.7	0.85 10 1.2 100 0.7* 2		6	125	800	6	4/1	04
BCY58-9	TO-18	32	7	10 [†]	40 100 1 80 1000 10 1 250 500* 2 5	0.35 0.7	0.85 10 1.2 100 0.7* 2		6	125	800	6	4/1	04
BCY58-10	TO-18	32	7	10 [†]	40 100 1 80 1000 10 1 350 700* 2 5	0.35 0.7	0.85 10 1.2 100 0.7* 2		6	125	800	6	4/1	04
BCY59	TO-18	45	7	10 [†]	40 100 1 80 1000 10 1 125 700* 2 5	0.35 0.7	0.85 10 1.2 100 0.7* 2		6	125	800	6	4/1	04
BCY59-7	TO-18	45	7	10 [†]	40 100 1 80 1000 10 1 125 250* 2 5	0.35 0.7	0.85 10 1.2 100 0.7* 2		6	125	800	6	4/1	04
BCY59-8	TO-18	45	7	10 [†]	40 100 1 80 1000 10 1 175 350* 2 5	0.35 0.7	0.85 10 1.2 100 0.7* 2		6	125	800	6	4/1	04
BCY59-9	TO-18	45	7	10 [†]	40 100 1 80 1000 10 1 250 500* 2 5	0.35 0.7	0.85 10 1.2 100 0.7* 2		6	125	800	6	4/1	04

6501130 NATL SEMICOND, (DISCRETE)

28C 35528

7-33-01



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} *		V _{CEO} (V) Min	V _{BE} O (V) Min		I _{CS} * (nA) Max	H _{FE} I _{hfe} 1 kHz*		I _C & V _{CE} (V)		V _{CE(SAT)} & V _{BE(ON)} * (V)		C _{ob} (pF) Max	f _T (MHz)		t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
		Min	Max		Min	Max		Min	Max	Min	Max	Min	Max		Min	Max				
BCY59-10	TO-18	45	10†	45	7	45	100	40	1000	1	1	0.35	0.6	6	125	10	800	6	4/1	04
BCY70	TO-18	40	10	40	5	40	0.1	40	700*	2	5	0.7	0.75	6	250	10	420	6	5/6	71
BCY71	TO-18	45	500	45	5	45	0.01	40	1	1	1	0.25	0.6	6	200	10		2	6	71
BCY71A	TO-18	45	500	45	5	45	0.1	80	1	1	1	0.25	0.6	6	300	10	420	2	6	71
BCY72	TO-18	25	500	25	5	25	1	40	10	1	1	0.25	0.6	6	200	10	420	6	5/6	71
BD135	TO-126	45	100	45	5	45	500	25	500	2	2	0.5	1.0*	6	50	50	420	6	5/6	37
BD135-6	TO-126	45	100	45	5	45	150	40	250	2	2	0.5	1.0*	6	50	50	420	6	5/6	37
BD135-10	TO-126	45	100	45	5	45	150	25	150	2	2	0.5	1.0*	6	50	50	420	6	5/6	37
BD135-16	TO-126	45	100	45	5	45	150	25	150	2	2	0.5	1.0*	6	50	50	420	6	5/6	37
BD136	TO-126	45	100	45	5	45	150	40	250	2	2	0.5	1.0*	6	50	50	420	6	5/6	37
BD136-6	TO-126	45	100	45	5	45	150	25	150	2	2	0.5	1.0*	6	50	50	420	6	5/6	37
BD136-10	TO-126	45	100	45	5	45	150	25	150	2	2	0.5	1.0*	6	50	50	420	6	5/6	37
BD136-16	TO-126	45	100	45	5	45	150	25	150	2	2	0.5	1.0*	6	50	50	420	6	5/6	37
BD137	TO-126	60	100	60	5	60	150	25	150	2	2	0.5	1.0*	6	50	50	420	6	5/6	38

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

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Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35529 D

T-33-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB} (V) Min	V _{CEO} (V) Min	V _{BE} (V) Min	I _{CS} [*] I _{CB} @ (nA) Max	h _{FE} h _{FE} @ 1 kHz Min Max	I _C & V _{CE} (mA) (V) Min Max	V _{CE(SAT)} (V) & V _{BE(ON)} [*] (V) Max Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BD137-6	TO-126	60	60	5	100	40 100	150 2	0.5	500		50	50				38
BD137-10	TO-126	60	60	5	100	63 160	150 2	0.5	500		50	50				38
BD138	TO-126	60	60	5	100	40 160	150 2	0.5	500		50	50				78
BD138-6	TO-126	60	60	5	100	40 100	150 2	0.5	500		50	50				78
BD138-10	TO-126	60	60	5	100	63 160	150 2	0.5	500		50	50				78
BD139	TO-126	80	80	5	100	25 500	500 2	0.5	500		50	50			5/6	39
BD139-6	TO-126	80	80	5	100	40 160	500 2	0.5	500		50	50				39
BD139-10	TO-126	80	80	5	100	25 500	500 2	0.5	500		50	50			5/6	39
BD140	TO-126	80	80	5	100	40 160	500 2	0.5	500		50	50				79
BD157	TO-126		250		100 μA	30 240	50 10									36
BD158	TO-126		300		100 μA	30 240	50 10									36
BD159	TO-126		350		100 μA	30 240	50 10									36
BD185	TO-126		30		100 μA	40 500	2 2A	1.0	1.2*	2A						4F
BD186	TO-126		30		100 μA	40 500	2 2A	1.0	1.5*	2A						5F
BD187	TO-126		45		100 μA	40 500	2 2A	1.0	1.5*	2A						4F
BD188	TO-126		45		100 μA	40 500	2 2A	1.0	1.5*	2A						5F
BD189	TO-126		60		100 μA	40 500	2 2A	1.0	1.5*	2A						4F
BD190	TO-126		60		100 μA	40 500	2 2A	1.0	1.5*	2A						5F
BD201	TO-220	60	45	5	10 μA	30 3A	2 2A	1.0	1.5*	3A	3	300	420	6	5/6	4A
BD202	TO-220	60	45	5	10 μA	30 3A	2 2A	1.0	1.5*	3A	3	300	420	6	5/6	5A

6501130 NATL SEMICOND, (DISCRETE)

28C 35530

F-33-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE0} [*] (V) Min	V _{CE0} [*] (V) Max	V _{BE0} [*] (V) Min	V _{BE0} [*] (V) Max	I _{CB0} [*] (nA) Max	I _{CB0} [*] (nA) Min	h _{FE} @ 1 kHz ⁺		I _C (mA) & V _{CE} (V)	V _{CE(SAT)} (V) & V _{BE(ON)} [*] (V)		I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
								Min	Max		Min	Max								
BD203	TO-220	60	5	5	5			30	30	2	2	1.0	3A		3					4A
BD204	TO-220	60	5	5	5	10 μA	40	30	30	2A	2	1.0	1.5* 3A							5A
BD220	TO-220	70						30	120	500	4	1.0	1.1* 500							4F
BD221	TO-220	40						30	120	1A	4	1.0	1.3* 1A							4F
BD222	TO-220	60						20	80	1.5A	4	1.0	1.5* 1.5A							4F
BD223	TO-220	70						30	120	300	4	1.0	1.1* 500							5F
BD224	TO-220	40						30	120	1A	4	1.0	1.3* 1A							5F
BD225	TO-220	60						20	80	1.5A	4	1.0	1.5* 1.5A							5F
BD233	TO-126	45				100 μA	45	25	40	1A	2	0.6	1.3* 1A		3	250	420	6	5/6	4F
BD234	TO-126	45				100 μA	45	25	40	150	2	0.6	1.3* 1A		3	250	420	6	5/6	5F
BD235	TO-126	60				100 μA	60	25	40	150	2	0.6	1.3* 1A		3	250	420	6	5/6	4F
BD236	TO-126	60				100 μA	60	25	40	150	2	0.6	1.3* 1A		3	250	420	6	5/6	5F
BD237	TO-126	80				100 μA	80	25	40	150	2	0.6	1.3* 1A		3	250	420	6	5/6	4F
BD238	TO-126	80				100 μA	80	25	40	150	2	0.6	1.3* 1A		3	250	420	6	5/6	5F
BD239	TO-220	45				200 μA*	45	15	40	1A	4	0.7	1.3* 1A		3	200	420	6	5/6	4F
BD239A	TO-220	60				200 μA*	60	15	40	1A	4	0.7	1.3* 1A		3	200	420	6	5/6	4F
BD239B	TO-220	80				200 μA*	80	15	40	1A	4	0.7	1.3* 1A		3	200	420	6	5/6	4F
BD239C	TO-220	100				200 μA*	100	15	40	1A	4	0.7	1.3* 1A		3	200	420	6	5/6	4F
BD240	TO-220	45				200 μA*	45	15	40	1A	4	0.7	1.3* 1A		3	200	420	6	5/6	5F
BD240A	TO-220	60				200 μA*	60	15	40	1A	4	0.7	1.3* 1A		3	200	420	6	5/6	5F

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_C = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_C = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_C = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_C = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

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Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35531 D

7-33-01

Pro Electron Series

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*]		V _{EB}	I _{CS} [*]		HFE		I _C & V _{CE}	V _{BE(SAT)} & V _{BE(ON)} [*]		C _{ob}	f _T		I _C	t _{off}	NF	Test Conditions	Process No.
		V _{CE0}	V _{CEB}		I _{CS0}	V _{CB}	h _{FE}	h _{FE}		Min	Max		Min	Max					
BD240B	TO-220	80	80		200 μA*	80	15	40	1A 4	0.7	1.3*	1A	3	200	420	6	5/6	5F	
BD240C	TO-220	100	100		200 μA*	100	15	40	1A 4	0.7	1.3*	1A	3	200	420	6	5/6	5F	
BD241	TO-220	80	45		200 μA*	45	10	25	3A 4	1.3	1.8*	3A	3	500	420	6	5/6	4F	
BD241A	TO-220	80	60		200 μA*	60	10	25	3A 4	1.3	1.8*	3A	3	500	420	6	5/6	4F	
BD241B	TO-220	80	80		200 μA*	80	10	25	3A 4	1.3	1.8*	3A	3	500	420	6	5/6	4F	
BD241C	TO-220	80	100		200 μA*	100	10	25	3A 4	1.3	1.8*	3A	3	500	420	6	5/6	4F	
BD242	TO-220	80	45		200 μA*	45	10	25	3A 4	1.2	1.8*	3A	3	500	420	6	5/6	5E	
BD242A	TO-220	80	60		200 μA*	60	10	25	3A 4	1.2	1.8*	3A	3	500	420	6	5/6	5E	
BD242B	TO-220	80	80		200 μA*	80	10	25	3A 4	1.2	1.8*	3A	3	500	420	6	5/6	5E	
BD242C	TO-220	80	100		200 μA*	100	10	25	3A 4	1.2	1.8*	3A	3	500	420	6	5/6	5E	
BD243	TO-220		45		400 μA*	45	30	15	300 4				3	500				4A	
BD243A	TO-220		60		400 μA*	60	30	15	300 4				3	500				4A	
BD243B	TO-220		80		400 μA*	80	30	15	300 4				3	500				4A	
BD243C	TO-220		100		400 μA*	100	30	15	300 4				3	500				4A	
BD244	TO-220		45		400 μA*	45	30	15	300 4									4A	
BD244A	TO-220		60		400 μA*	60	30	15	300 4									5A	
BD244B	TO-220		80		400 μA*	80	30	15	300 4				3	500				5A	
BD244C	TO-220		100		400 μA*	100	30	15	300 4				3	500				5A	
BD344	TO-126	60	60	5	500	60	60	40	50 200	0.4		200	50	50				78	

6501130 NATL SEMICOND, (DISCRETE)

28C 35532

D

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE0} [*] (V)		V _{CE0} [*] (V)		V _{BE0} (V)		I _{CB0} @ V _{CB} (mA)		h _{FE} @ I _C & V _{CE} (mA, V)		V _{CE(SAT)} (V)		V _{BE(SAT)} & V _{BE(ON)} [*] (V)		C _{ob} (pF)		f _T (MHz)		t _{off} (ns)		NF (dB) Max	Test Conditions	Process No.
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max			
BD345	TO-126	60	60	5	500	60	60	50	1	60	40	250	200	200	200	200	200	20	50	50			38	
BD346	TO-220	60			10 μA	60	60	140	2A	40	140	2A	2.5	2.5			200	4	4	250			5A	
BD347	TO-220	60			10 μA	60	60	140	2A	40	140	2A	2.5	2.5			200	4	4	250			4A	
BD348	TO-126	80	80	5	500	80	80	100	1	60	60	250	250	1	0.5	250	17	17	50	50			79	
BD349	TO-126	80	80		500	80	80	100	1	60	60	250	250	1	0.5	250	15	15	50	50			39	
BD370A	TO-237 (91)	45	45		100	45	45	25	500	25	25	500	2	2	0.7	1.2* 1A	30	30	50	200	420	6	5/6	78
BD370A-10	TO-237 (91)	45	45		100	45	45	25	500	25	25	500	2	2	0.7	1.2* 1A	30	30	50	200	420	6	5/6	78
BD370A-16	TO-237 (91)	45	45		100	45	45	25	500	25	25	500	2	2	0.7	1.2* 1A	30	30	50	200	420	6	5/6	78
BD370A-25	TO-237 (91)	45	45		100	45	45	25	500	25	25	500	2	2	0.7	1.2* 1A	30	30	50	200	420	6	5/6	78
BD370B	TO-237 (91)	60	60		100	60	60	40	100	40	40	100	1	1	0.7	1.2* 1A	30	30	50	200	420	6	5/6	78
BD370B-10	TO-237 (91)	60	60		100	60	60	40	100	40	40	100	1	1	0.7	1.2* 1A	30	30	50	200	420	6	5/6	78
BD370B-16	TO-237 (91)	60	60		100	60	60	40	100	40	40	100	1	1	0.7	1.2* 1A	30	30	50	200	420	6	5/6	78
BD370B-25	TO-237 (91)	60	60		100	60	60	40	100	40	40	100	1	1	0.7	1.2* 1A	30	30	50	200	420	6	5/6	78
BD370C	TO-237 (91)	80	80		100	80	80	40	100	40	40	100	1	1	0.7	1.2* 1A	30	30	50	200	420	6	5/6	78
BD370C-6	TO-237 (91)	80	80		100	80	80	40	100	40	40	100	1	1	0.7	1.2* 1A	30	30	50	200	420	6	5/6	78
BD370C-10	TO-237 (91)	80	80		100	80	80	40	100	40	40	100	1	1	0.7	1.2* 1A	30	30	50	200	420	6	5/6	78
BD370C-16	TO-237 (91)	80	80		100	80	80	40	100	40	40	100	1	1	0.7	1.2* 1A	30	30	50	200	420	6	5/6	78

T-33-01

TEST CONDITIONS: (1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

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6501130 NATL SEMICOND, (DISCRETE)

28C 35533 D

T-33-01

Pro Electron Series

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE0} [*] (V) Min	V _{CE0} [*] (V) Max	V _{BE0} (V) Min	I _{CE0} [*] (mA) Max	V _{CB} (V)	HFE		I _C & V _{CE}		V _{CE(SAT)} & V _{BE(ON)} [*]		C _{cb} (pF) Max	f _T		t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
							Min	Max	Min	Max	Min	Max		Min	Max				
BD370D	TO-237 (91)	100	80	80	100	80	25	40	500	2	0.7	1.2*	30	50	200	420	6	5/6	79
BD370D-6	TO-237 (91)	100	80	80	100	80	25	40	500	2	0.7	1.2*	30	50	200	420	6	5/6	79
BD370D-10	TO-237 (91)	100	80	80	100	80	25	63	500	2	0.7	1.2*	30	50	200	420	6	5/6	79
BD371A	TO-237 (91)	45	80	45	100	45	25	40	500	2	0.7	1.2*	30	50	200	420	6	5/6	38
BD371A-10	TO-237 (91)	45	80	45	100	45	25	63	500	2	0.7	1.2*	30	50	200	420	6	5/6	38
BD371A-16	TO-237 (91)	45	80	45	100	45	25	100	500	2	0.7	1.2*	30	50	200	420	6	5/6	38
BD371A-25	TO-237 (91)	45	80	45	100	45	25	180	500	2	0.7	1.2*	30	50	200	420	6	5/6	38
BD371B	TO-237 (91)	60	80	60	100	60	25	40	500	2	0.7	1.2*	30	50	200	420	6	5/6	38
BD371B-10	TO-237 (91)	60	80	60	100	60	25	63	500	2	0.7	1.2*	30	50	200	420	6	5/6	38
BD371B-16	TO-237 (91)	60	80	60	100	60	25	100	500	2	0.7	1.2*	30	50	200	420	6	5/6	38
BD371B-25	TO-237 (91)	60	80	60	100	60	25	160	500	2	0.7	1.2*	30	50	200	420	6	5/6	38
BD371C	TO-237 (91)	80	80	80	100	80	25	40	500	2	0.7	1.2*	30	50	200	420	6	5/6	38
BD371C-6	TO-237 (91)	80	80	80	100	80	25	63	500	2	0.7	1.2*	30	50	200	420	6	5/6	38
BD371C-10	TO-237 (91)	80	80	80	100	80	25	100	500	2	0.7	1.2*	30	50	200	420	6	5/6	38
BD371C-16	TO-237 (91)	80	80	80	100	80	25	160	500	2	0.7	1.2*	30	50	200	420	6	5/6	38
BD371D	TO-237 (91)	100	80	100	100	100	25	40	500	2	0.7	1.2*	30	50	200	420	6	5/6	39
BD371D-6	TO-327 (91)	100	80	100	100	100	25	40	500	2	0.7	1.2*	30	50	200	420	6	5/6	39
BD371D-10	TO-237 (91)	100	80	100	100	100	25	63	500	2	0.7	1.2*	30	50	200	420	6	5/6	39
BD372A	TO-237 (90)	45	80	45	100	45	25	40	500	2	0.7	1.2*	30	50	200	420	6	5/6	78

6501130 NATL SEMICOND, (DISCRETE)

28C 35534

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PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} * V _{CSO} (V) Min	V _{CEO} (V) Min	V _{EBO} (V) Min	I _{CS} * I _{CSO} (mA) Max	V _{CB} (V) Max	H _{FE} h _{FE} 1 kHz*		I _C & V _{CE} (mA) (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} * (V) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
							Min	Max											
BD372A-10	TO-237 (90)	80	45		100	45	25 63	500 160	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372A-16	TO-237 (90)	80	45		100	45	25 100	500 250	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372A-25	TO-237 (90)	80	45		100	45	25 160	500 400	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372B	TO-237 (90)	80	60		100	60	25 40	500 400	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372B-10	TO-237 (90)	80	60		100	60	25 63	500 160	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372B-16	TO-237 (90)	80	60		100	60	25 100	500 250	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372B-25	TO-237 (90)	80	60		100	60	25 160	500 400	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372C	TO-237 (90)	80	80		100	80	25 40	500 400	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372C-6	TO-237 (90)	80	80		100	80	25 40	500 100	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372C-10	TO-237 (90)	80	80		100	80	25 63	500 160	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372C-16	TO-237 (90)	80	100		100	100	25 100	500 250	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372D	TO-237 (90)	80	100		100	100	25 40	500 400	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	79
BD372D-6	TO-237 (90)	80	100		100	100	25 40	500 100	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	79
BD372D-10	TO-237 (90)	80	100		100	100	25 63	500 160	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	79
BD373A	TO-237 (90)	80	45		100	45	25 40	500 400	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD373A-10	TO-237 (90)	80	45		100	45	25 63	500 160	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD373A-16	TO-237 (90)	80	45		100	45	25 100	500 250	2 1	0.7	1.2*	1A	30	50	200	420	6	5/6	38

TEST CONDITIONS:
 (1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CC} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CC} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CC} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CC} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

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6501130 NATL SEMICOND, (DISCRETE)

28C 35535 D

Pro Electron Series

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB} (V) Min	V _{CE} [*] (V) Min	V _{EB} (V) Min	I _{CE} [*] I _{CB} (mA) Max	HFE h _{FE} 1 kHz [*] Min Max	I _C & V _{CE} (mA) & (V) Min Max	V _{CE(SAT)} & V _{BE(ON)} [*] (V) & (V) Min Max	I _C (mA) Min Max	C _{ob} (pF) Max	f _T (MHz) Min Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BD373A-25	TO-237 (90)	80	45		100	25 160	500 2 400 1	0.7 1.2 [*]	1A	30	50	420	6	5/6	38
BD373B	TO-237 (90)	80	80		100	25 40	500 2 400 1	0.7 1.2 [*]	1A	30	50	420	6	5/6	38
BD373B-10	TO-237 (90)	80	80		100	25 63	500 2 160 1	0.7 1.2 [*]	1A	30	50	420	6	5/8	38
BD373B-16	TO-237 (90)	80	60		100	25 100	500 2 250 1	0.7 1.2 [*]	1A	30	50	420	6	5/8	38
BD373B-25	TO-237 (90)	80	60		100	25 160	500 2 400 1	0.7 1.2 [*]	1A	30	50	420	6	5/6	38
BD373C	TO-237 (90)	80	80		100	25 40	500 2 400 1	0.7 1.2 [*]	1A	30	50	420	6	5/6	38
BD373C-6	TO-237 (90)	80	80		100	25 40	500 2 100 1	0.7 1.2 [*]	1A	30	50	420	6	5/6	38
BD373C-10	TO-237 (90)	80	80		100	25 63	500 2 160 1	0.7 1.2 [*]	1A	30	50	420	6	5/6	38
BD373C-16	TO-237 (90)	80	80		100	25 100	500 2 250 1	0.7 1.2 [*]	1A	30	50	420	6	5/6	38
BD373D	TO-237 (90)	80	100		100	25 40	500 2 400 1	0.7 1.2 [*]	1A	30	50	420	6	5/6	39
BD373D-6	TO-237 (90)	80	100		100	25 40	500 2 100 1	0.7 1.2 [*]	1A	30	50	420	6	5/6	39
BD373D-10	TO-237 (90)	80	100		100	25 63	500 2 160 1	0.7 1.2 [*]	1A	30	50	420	6	5/6	39
BD375	TO-126	50	45		2 μA	20 40	1A 2 375 2	1.0 1.5 [*]	1A	30	50	420	6	5/6	38
BD375-6	TO-126	50	45		2 μA	20 40	1A 2 100 2	1.0 1.5 [*]	1A	30	50	420	6	5/6	38
BD375-10	TO-126	50	45		2 μA	20 63	1A 2 160 2	1.0 1.5 [*]	1A	30	50	420	6	5/6	38
BD375-16	TO-126	50	45		2 μA	20 100	1A 2 250 2	1.0 1.5 [*]	1A	30	50	420	6	5/6	38
BD375-25	TO-126	50	45		2 μA	20 150	1A 2 375 2	1.0 1.5 [*]	1A	30	50	420	6	5/6	38
BD376	TO-126	50	45		2 μA	20 40	1A 2 100 2	1.0 1.5 [*]	1A	30	50	420	6	5/6	78
BD376-6	TO-126	50	45		2 μA	20 40	1A 2 150 2	1.0 1.5 [*]	1A	30	50	420	6	5/6	78

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6501130 NATL SEMICOND, (DISCRETE)

28C 35536

D

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE0} [*] (V) Min	V _{CE0} [*] (V) Max	V _{ES0} (V) Min	I _{CS} [*] (mA) Max	h _{FE} @ 1 kHz [*] Min	h _{FE} @ 1 kHz [*] Max	I _C & V _{CE} (mA) & (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V)		C _{ob} (pF) Max	f _T (MHz)		I _C (mA)	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
										Min	Max		Min	Max					
BD376-10	TO-126	50	45		2 μA	20	160	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	78
BD376-16	TO-126	50	45		2 μA	63	200	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	78
BD376-25	TO-126	50	45		2 μA	20	375	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	78
BD377	TO-126	75	60		2 μA	40	375	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	38
BD377-6	TO-126	75	60		2 μA	40	100	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	38
BD377-10	TO-126	75	60		2 μA	63	160	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	38
BD377-16	TO-126	75	60		2 μA	20	250	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	38
BD377-25	TO-126	75	60		2 μA	20	375	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	38
BD378	TO-126	75	60		2 μA	40	375	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	78
BD378-6	TO-126	75	60		2 μA	20	100	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	78
BD378-10	TO-126	75	60		2 μA	63	160	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	78
BD378-16	TO-126	75	60		2 μA	20	250	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	78
BD378-25	TO-126	75	60		2 μA	20	375	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	78
BD379	TO-126	100	80		2 μA	20	375	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	39
BD379-6	TO-126	100	80		2 μA	40	100	1A 2	1.0	1.5*	1A	30	50		200	420	6	5/6	39

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TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

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6501130 NATL SEMICOND, (DISCRETE)

28C 35537 D

Pro Electron Series

Type No.	Case Style	V _{CE0} [*] (V) Min	V _{CE0} [*] (V) Max	V _{CB0} [*] (V) Min	V _{CB0} [*] (V) Max	I _{CB0} [*] (mA) Min	I _{CB0} [*] (mA) Max	h _{FE} 1 kHz [*] Min	h _{FE} 1 kHz [*] Max	I _C & V _{CE} (mA) & (V) Min	I _C & V _{CE} (mA) & (V) Max	V _{CE(SAT)} & V _{BE(ON)} [*] (V) & (V)		I _C @ (mA)		C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
												Max	Min	Max	Min								
BD379-10	TO-126	80	80	2	80	2	2	20	63	1A	150	2	1.0	1.5*	1A	30	50	200	420	5/6	39		
BD379-16	TO-126	80	80	2	80	2	2	100	250	1A	150	2	1.0	1.5*	1A	30	50	200	420	5/6	39		
BD379-25	TO-126	80	80	2	80	2	2	150	375	1A	150	2	1.0	1.5*	1A	30	50	200	420	5/6	39		
BD380	TO-126	80	80	2	80	2	2	40	375	1A	150	2	1.0	1.5*	1A	30	50	200	420	5/6	79		
BD380-6	TO-126	80	80	2	80	2	2	40	100	1A	150	2	1.0	1.5*	1A	30	50	200	420	5/6	79		
BD380-10	TO-126	80	80	2	80	2	2	63	160	1A	150	2	1.0	1.5*	1A	30	50	200	420	5/6	79		
BD380-16	TO-126	80	80	2	80	2	2	100	250	1A	150	2	1.0	1.5*	1A	30	50	200	420	5/6	79		
BD380-25	TO-126	80	80	2	80	2	2	150	375	1A	150	2	1.0	1.5*	1A	30	50	200	420	5/6	79		
BD433	TO-126	22	22	5	22	5	5	50	475	2A	500	1	0.5	1.1*	2A		3	250	420	5/6	4E		
BD434	TO-126	22	22	5	22	5	5	40	475	2A	500	1	0.5	1.1*	2A	30	3	250	420	5/6	5E		
BD435	TO-126	32	32	5	32	5	5	50	475	2A	500	1	0.5	1.1*	2A	30	3	250	420	5/6	4E		
BD436	TO-126	32	32	5	32	5	5	40	475	2A	500	1	0.5	1.1*	2A	30	3	250	420	5/6	5E		
BD437	TO-126	45	45	5	45	5	5	40	236	2A	500	1	0.6	1.2*	2A	30	3	250	420	5/6	4E		
BD438	TO-126	45	45	5	45	5	5	40	236	2A	500	1	0.6	1.2*	2A	30	3	250	420	5/6	5E		
BD439	TO-126	60	60	5	60	5	5	25	236	2A	500	1	0.8	1.5*	2A	30	3	250	420	5/6	4E		

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6501130 NATL SEMICOND, (DISCRETE)

28C 35538

T-33-01

Type No.	Case Style	V _{CE0} (V)		V _{CE0} (V) Min	V _{CE0} (V) Min	V _{CB} (V) Min	I _{CB0} (mA) Max	h _{FE} @ 1 kHz*		I _C & V _{CE} (mA) (V)	V _{CE(SAT)} & V _{BE(ON)} * (V)		I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
		Min	Max					Min	Max		Min	Max								
BD440	TO-126	60†	60	5	100 μA	60	25 40	2A 500	1 5	0.8	1.5*	2A	80	3	250	420	5/6	5E		
BD441	TO-126	80†	80	5	100 μA	80	15 40	2A 500	1 5	0.8	1.5*	2A	30	3	250	420	5/6	4E		
BD442	TO-126	80†	80	5	100 μA	80	15 40	2A 500	1 5	0.8	1.5*	2A	30	3	250	420	5/6	5E		
BD533	TO-220	80†	45	5	100 μA	45	25 40	2A 500	2 5	0.8	1.5*	2A	30	3	250	420	5/6	4E		
BD534	TO-220	80†	45	5	100 μA	45	25 40	2A 500	2 5	0.8	1.5*	2A	30	3	250	420	5/6	5E		
BD535	TO-220	80†	60	5	100 μA	60	25 40	2A 500	2 5	0.8	1.5*	2A	30	3	250	420	5/6	4E		
BD536	TO-220	80†	60	5	100 μA	60	25 40	2A 500	2 5	0.8	1.5*	2A	30	3	250	420	5/6	5E		
BD537	TO-220	80†	80	5	100 μA	80	15 40	2A 500	2 5	0.8	1.5*	2A	30	3	250	420	5/6	4E		
BD538	TO-220	80†	80	5	100 μA	80	15 40	2A 500	2 5	0.8	1.5*	2A	30	3	250	420	5/6	5E		
BD633	TO-220	45	45	5	200 μA†	45	25 40	1A 25	2 2	0.6	1.3*	1A	30	3	250	420	5/6	4F		
BD634	TO-220	45	45	5	200 μA†	45	25 40	1A 25	2 2	0.6	1.3*	1A	30	3	250	420	5/6	5F		
BD635	TO-220	60	60	5	200 μA†	60	25 40	1A 25	2 2	0.6	1.3*	1A	30	3	250	420	5/6	4F		

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.



PRO ELECTRON SERIES (Continued)

Pro Electron Series

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6501130 NATL SEMICOND, (DISCRETE)

28C 35539 D

Pro Electron Series

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PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE0} (V)		V _{BE0} (V)	I _{CS0} (mA)	I _{CB} (mA)	H _{FE} (1 kHz)		I _C (mA)	V _{CE} (V)	V _{BE(SAT)} & V _{BE(ON)} (V)		I _C (mA)	C _{ob} (pF)	f _T (MHz)	I _C (mA)	t _{off} (ns)	NF (dB)	Test Conditions	Process No.
		Min	Max				Min	Max			Min	Max								
BD636	TO-220	60	60	5	200 μA†	60	25	40	1A	2	0.6	1.3*	1A	30	3	250	420	6	5/6	5F
BD637	TO-220	100	80	5	200 μA†	100	25	40	1A	2	0.6	1.3*	1A	30	3	250	420	6	5/6	4F
BD638	TO-220	100	80	5	200 μA†	100	25	40	1A	2	0.6	1.3	1A	30	3	250	420	6	5/6	5F
BD675	TO-126		45		200 μA	45	750		1.5A	3	2.5	2.5*	1.5A		1	1.5A				4J
BD675A	TO-126		45		200 μA	45	750		2A	3	2.8	2.5*	2A		1	1.5A				4J
BD676	TO-126		45		200 μA	45	750		1.5A	3V	2.5	2.5*	1.5A		1	1.5A				5J
BD676A	TO-126		45		200 μA	45	750		2A	3V	2.5	2.5*	2A		1	1.5A				5J
BD677	TO-126		60		200 μA	60	750		1.5A	3V	2.5	2.5*	1.5A		1	1.5A				4J
BD677A	TO-126		60		200 μA	60	750		2A	3V	2.8	2.5*	2A		1	1.5A				4J
BD678	TO-126		60		200 μA	60	750		1.5A	3V	2.5	2.5*	1.5A		1	1.5A				5J
BD678A	TO-126		60		200 μA	60	750		2A	3V	2.8	2.5*	2A		1	1.5A				5J
BD679	TO-126		80		200 μA	80	750		1.5A	3V	2.5	2.5*	1.5A		1	1.5A				4J
BD679A	TO-126		80		200 μA	80	750		2A	3V	2.8	2.5*	2A		1	1.5A				4J
BD680	TO-126		80		200 μA	80	750		1.5A	3V	2.5	2.5*	1.5A		1	1.5A				4J
BD680A	TO-126		80		200 μA	80	750		2A	3V	2.5	2.5*	2A		1	1.5A				5J
BD681	TO-126		100		200 μA	100	750		1.5A	3V	2.5	2.5*	1.5A		1	1.5A				5J
BD682	TO-126		100		200 μA	100	750		1.5A	3V	2.5	2.5*	1.5A		1	1.5A				4J
BD733	TO-220	25	25	5	200 μA†	25	50	40	2A	1	0.6	1.1*	2A		1	1.5A				4F
BD734	TO-220	25	25	5	200 μA†	25	50	40	2A	1	0.6	1.1*	2A		1	1.5A				5E
BD735	TO-220	35	35	5	200 μA†	35	40	40	2A	4	0.6	1.1*	2A		1	1.5A				4F
BD736	TO-220	35	35	5	200 μA†	35	40	40	2A	1	0.6	1.1*	2A		1	1.5A				5E
BD737	TO-220	45	45	5	200 μA†	45	40	40	2A	4	0.6	1.1*	2A		1	1.5A				4F
BD738	TO-220	45	45	5	200 μA†	45	40	40	2A	1	0.8	1.1*	2A		1	1.5A				5E
BD795	TO-220		45		200 μA†	45	40	40	2A	4	0.8	1.1*	2A		1	1.5A				4E
BD796	TO-220		45		100	45	40	40	1A	2	1.0	1.6*	3A		3	250				5E
BD797	TO-220		60		100 μA	60	40	40	1A	2	1.0	1.6*	3A		3	250				4E

6501130 NATL SEMICOND, (DISCRETE)

28C 35540

T-33-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE0} [*] (V) Min	V _{CE0} [*] (V) Max	V _{BE0} (V) Min	V _{BE0} (V) Max	I _{CB0} [*] (mA) Max	I _{CB0} [*] (mA) Min	HFE I _h 1 kHz [*] Min	HFE I _h 1 kHz [*] Max	I _C & V _{CE} (mA) & (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} (V) Min	I _C (mA) Max	I _C (mA) Min	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BD798	TO-220	60	100	60	100	100	100	40	25	1A 2 3A 2	1.0	1.6*	3A	250		3					5E
BD799	TO-220	80	100	80	100	100	100	30	15	1A 2 3A 2	1.0	1.6*	3A	250		3					4E
BD800	TO-220	80	100	80	100	100	100	30	15	1A 2 3A 2	1.0	1.6*	3A	250		3					5E
BD801	TO-220	100	100	100	100	100	100	30	15	1A 2 3A 2	1.0	1.6*	3A	250		3					4E
BD802	TO-220	100	100	100	100	100	100	30	15	1A 2 3A 2	1.0	1.6*	3A	250		3					5E
BD895	TO-220	45	200	45	200	200	200	750	45	3A 3	2.5*	2.5*	3A	3A		1					4K
BD895A	TO-220	45	200	45	200	200	200	750	45	4A 3	2.5*	2.5*	4A	3A		1					4K
BD896	TO-220	45	200	45	200	200	200	750	45	3A 3	2.5*	2.5*	3A	3A		1					5K
BD896A	TO-220	45	200	45	200	200	200	750	45	4A 3	2.5*	2.5*	4A	3A		1					5K
BD897	TO-220	60	200	60	200	200	200	750	45	3A 3	2.5*	2.5*	3A	3A		1					4K
BD897A	TO-220	60	200	60	200	200	200	750	45	4A 3	2.5*	2.5*	4A	3A		1					4K
BD898	TO-220	60	200	60	200	200	200	750	45	3A 3	2.5*	2.5*	3A	3A		1					5K
BD898A	TO-220	60	200	60	200	200	200	750	45	4A 3	2.5*	2.5*	4A	3A		1					5K
BD899	TO-220	80	200	80	200	200	200	750	45	3A 3	2.5*	2.5*	3A	3A		1					4K
BD899A	TO-220	80	200	80	200	200	200	750	45	4A 3	2.5*	2.5*	4A	3A		1					4K
BD900	TO-220	80	200	80	200	200	200	750	45	3A 3	2.5*	2.5*	3A	3A		1					5K
BD900A	TO-220	80	200	80	200	200	200	750	45	4A 3	2.5*	2.5*	4A	3A		1					5K
BD901	TO-220	100	200	100	200	200	200	750	45	3A 3	2.5*	2.5*	3A	3A		1					4K
BD901A	TO-220	100	200	100	200	200	200	750	45	4A 3	2.5*	2.5*	4A	3A		1					4K
BDX33	TO-220	45	1 mA	45	1 mA	1 mA	1 mA	750	45	4A 3	2.5*	2.5*	4A	1A		20					4K
BDX33A	TO-220	60	1 mA	60	1 mA	1 mA	1 mA	750	45	4A 3	2.5*	2.5*	4A	1A		20					4K
BDX33B	TO-220	80	1 mA	80	1 mA	1 mA	1 mA	750	45	3A 3	2.5*	2.5*	3A	1A		20					4K
BDX33C	TO-220	100	1 mA	100	1 mA	1 mA	1 mA	750	45	3A 3	2.5*	2.5*	3A	1A		20					4K
BDX33D	TO-220	120	1 mA	120	1 mA	1 mA	1 mA	750	45	3A 3	2.5*	2.5*	3A	1A		20					4K
BDX34	TO-220	45	1 mA	45	1 mA	1 mA	1 mA	750	45	4A 3	2.5*	2.5*	4A	1A		20					5K
BDX34A	TO-220	60	1 mA	60	1 mA	1 mA	1 mA	750	45	4A 3	2.5*	2.5*	4A	1A		20					5K
BDX34B	TO-220	80	1 mA	80	1 mA	1 mA	1 mA	750	45	3A 3	2.5*	2.5*	3A	1A		20					5K

TEST CONDITIONS:
 (1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

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6501130 NATL SEMICOND, (DISCRETE)

28C 35541 D

Pro Electron Series

7-31-01

Type No.	Case Style	V _{CE0} [*] (V)		V _{BE0} (V)		I _{CB0} [*] (mA)		h _{FE} @ 1 kHz		I _C & V _{CE} (V)		V _{CE(SAT)} (V)		V _{BE(SAT)} (V)		I _C (mA)		C _{ob} (pF) Max	f _T (MHz)		t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.	
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max		Min	Max					
BDX34C	TO-220	100	100	100	100	1 mA	100	3A	3	3A	3	2.5*	3A	1A					20	20	1A			5K	
BDX34D	TO-220	120	120	1 mA	120	1 mA	120	3A	3	3A	3	2.5*	3A	1A					20	20	1A			5K	
BF167	TO-72 (28)	40	30	4	100	100	30	4	10			0.84*	4											45	
BF180	TO-72 (25)	30	20	3	100	100	20	2	10															41	
BF181	TO-72 (25)	30	20	3	100	100	20	2	10															41	
BF194	TO-92 (98)	Same as BF254, see page 5-33 for explanation																							
BF195	TO-92 (98)	Same as BF255, see page 5-33 for explanation																							
BF196	TO-92 (98)	Same as BF198, see below for explanation																							
BF197	TO-92 (98)	Same as BF199, see below for explanation																							
BF198	TO-92 (98)	40	30	4	100	100	40	26	4	10	7	0.85*	4											45	
BF199	TO-92 (98)	40	25	4	100	100	40	36	7	10	7									1100 typ	7			47	
BF200	TO-72 (25)	30	20	3	100	100	40	15	3	10	7													41	
BF233-2	TO-92 (96)	30	30	4	100	100	10	40	70	1	10	0.65	0.74*	1					1.0		150	1		49	
BF233-3	TO-92 (96)	30	30	4	100	100	10	60	100	1	10	0.65	0.74*	1					1.0		150	1		49	
BF233-4	TO-92 (96)	30	30	4	100	100	10	90	150	1	10	0.65	0.74*	1					1.0		150	1		49	
BF233-5	TO-92 (96)	30	30	4	100	100	10	140	220	1	10	0.65	0.74*	1					1.0		150	1		49	
BF237	TO-92 (98)	45	30	4	100	100	20	6			7	0.25												47	
BF238	TO-92 (98)	45	30	4	100	100	20	6			7	0.25												47	
BF240	TO-92 (98)	40	40	4	100	100	20	67	222	1	10	0.65	0.74*	1					0.34				3.5	7	47
BF241	TO-92 (98)	40	40	4	100	100	20	36	125	1	10	0.65	0.74*	1					0.34				3.5	7	47

6501130 NATL SEMICOND, (DISCRETE)

28C 35542

D

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE0} [*] (V)		V _{BE0} (V)		I _{CB0} [*] (nA)		h _{FE} @ 1 kHz [*]		I _C & V _{CE} (V)		V _{CE(SAT)} (V) & V _{BE(ON)} [*] (V)		V _{BE(SAT)} (V) & V _{BE(ON)} [*] (V)		C _{ob} (pF)		f _T (MHz)		t _{off} (ns)		NF (dB) Max	Test Conditions	Process No.	
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max				
BF254	TO-92 (98)	20	30	5	100	20	100	20	12	10	7	0.65	0.74*	1	0.34							3.5	7	46	
BF255	TO-92 (98)	20	30	5	100	20	100	36	125	10	7	0.65	0.74*	1	0.34							3.5	7	46	
BF257	TO-39	100	300	5	50	100	50	25	30	10	7	1.0	0.74*	30	0.34							3.5	7	48	
BF258	TO-39	250	300	5	50	200	50	25	30	10	7	1.0	0.74*	30	0.34							3.5	7	48	
BF259	TO-39	300	300	5	50	250	50	25	30	10	7	1.0	0.74*	30	0.34							3.5	7	48	
BF457	TO-126	100	100	5	50	100	50	25	30	10	7	1.0	0.74*	30	0.34							3.5	7	48	
BF458	TO-126	200	200	5	50	200	50	25	30	10	7	1.0	0.74*	30	0.34							3.5	7	48	
BF459	TO-126	300	300	5	50	250	50	25	30	10	7	1.0	0.74*	30	0.34							3.5	7	48	
BFX13	TO-18	20	20	5	50	15	50	10	100	2	0.35	0.2	0.78	1	6	150	10					10	8	66	
BFX29	TO-5	20	20	5	50	50	50	50	250	10	0.25	0.25	0.7	0.9	10	100									63
BFX30	TO-5	65	65	5	50	50	50	20	150	10	0.4	0.4	1.3	150	12	290							4	63	
BFX37	TO-18	60	60	6	20†	50	20†	100	10	5	5	0.4	1.0	50	6	40	0.5					3	1	62	
BFX65	TO-18	45	45	6	10*	40	10*	70	300	0.01	5	0.25	0.9	10	6.5							3	1	62	

T-31-01

TEST CONDITIONS: (1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

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Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35543 D

T-31-01

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE} [*] V _{CB} (V) Min	V _{CE} [*] (V) Min	V _{EB} [*] (V) Min	I _{CB} [*] (mA) Max	HFE h _{FE} 1 kHz [*] Min Max	I _C & V _{CE} (mA) & (V) Min Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min Max	I _C (mA) Min Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BFX84	TO-39	45	45	6	500	15 20 30 20	1A 500 150 10	0.15 0.35 1.0 1.6	1.2 1.3 1.5 2.0	10 150 500 1A	12	50	50	360		9	14
BFX85	TO-39	45	45	6	50	15 30 70 50	1A 500 150 10	0.15 0.35 1.0 1.6	1.2 1.3 1.5 2.0	10 150 500 1A	12	50	50	360		9	14
BFX86	TO-39	45	45	6	50	15 30 70 50	1A 500 150 10	0.15 0.35 1.0 1.6	1.2 1.3 1.5 2.0	10 150 500 1A	12	50	50	360		9	14
BFX87	TO-5	45	50	6	50	25 40 40 40	500 150 10 1	0.4 0.9 0.9	1.3 1.5 2.0	150 30 1A	12	100	50	150		9	63
BFX88	TO-5	45	40	6	50	25 40 40 40	500 150 10 1	0.4 0.9 0.9	1.3 1.5 2.0	150 30 1A	12	100	50	150		9	63
BFY39	TO-18	45	25	5	50	35	400	1.0	1.0	10		150	10				23
BFY39-1	TO-18	45	25	5	50	35	110	1.0	1.0	10		150	10				23
BFY39-2	TO-18	45	25	5	50	100	200	1.0	1.0	10		150	10				23
BFY39-3	TO-18	45	25	5	50	180	400	1.0	1.0	10		150	10				23
BFY50	TO-18	80	35	6	500	20 30 20 15	10 150 10 1A	0.1 0.1 0.1	1.2 1.2 1.2	10 10 10	12	60	50	360		9	14
BFY51	TO-39	60	30	6	500	30 40 25 15	10 150 10 1A	0.1 0.1 0.1	1.2 1.2 1.2	10 10 10	12	60	50	360		9	14
BFY52	TO-39	40	20	6	500	30 60 30 15	10 150 10 1A	0.1 0.1 0.1	1.2 1.2 1.2	10 10 10	12	60	50	360		9	14
BFY56	TO-39	80	45	5	50	15 20 30	1 500 150	0.3 1.2	1.5 2.5	150 1A	25	40	50				14

6501130 NATL SEMICOND, (DISCRETE)

28C 35544

D



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB} (V)		V _{CE} (V) Min	V _{BE} (V) Min	V _{CE} [*] I _{CB} (mA) Max	HFE		V _{CE} (SAT) & V _{BE} (ON) [*] (V)		V _{BE} (SAT) & V _{BE} (ON) [*] (V)		C _{ob} (pF) Max	f _T (MHz)		t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
		Min	Max				Min	Max	Min	Max	Min	Max		Min	Max				
BFY72	TO-39	50	28	5	20	40*	15	20	0.1	10	0.25	1.2	8	50	50				19
BFY76	TO-18	45	45	6	30	20	30	200	0.01	5	0.35	1.6	6						
BSX21	TO-18		80			500	20	4	3		0.9	4		60	4				07
BSX45-6	TO-39	80*	40	7	60	10*	40	100	100	1	1.0	2.0	20	60	50				14
BSX45-10	TO-39	80*	40	7	60	10*	63	160	100	1	1.0	2.0	20	60	50				14
BSX45-16	TO-39	80*	40	7	60	10*	100	250	100	1	1.0	2.0	20	60	50				14
BSX46-6	TO-39	100*	60	7	60	10*	40	100	100	1	1.0	2.0	25	60	50				12
BSX46-10	TO-39	100*	60	7	60	10*	63	160	100	1	1.0	2.0	25	60	50				12
BSX46-16	TO-39	100*	60	7	60	10*	100	250	100	1	1.0	2.0	25	60	50				12
BSX48	TO-18	50	25	5	50	120	17	100	1	1.5	1.5	500	6	250	30				19
BSX88	TO-18	40	15	5	20	25	15	0.5	1	0.5	0.72	0.8	6	300	10				21
BSY38	TO-18	20	12	5	100	20	30	60	0.35	0.25	0.7	0.85	5	200	10	45		16	21
BSY39	TO-18	20	12	5	100	20	15	45	100	0.6	1.5	100	5	200	10	45		16	21
BSY51	TO-18	60	35	5	100	30	40	120	150	10	1.0	1.3	9	130	50				19
BSY52	TO-18	60	25	5	100	30	100	300	150	10	1.0	1.3	9	130	50				19
BSY53	TO-18	75	30	7	10	60	20	0.1	10	0.6	1.3	150	9	150	50				19

T-31-01

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

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Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35545 D

Pro Electron Series

T-31-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE0} [*] (V)		V _{BE0} (V)		I _{CB0} (mA)		HFE		I _C & V _{CE} (V)		V _{CE(SAT)} & V _{BE(ON)} [*] (V)		C _{ob} (pF)		f _T (MHz)		t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max				
BSY54	TO-18	75	30	7	60	10	10	35	75	10	10	0.6	1.3	9	150	50	150	50			19
BSY95A	TO-18	20	15	5	16	50	10	30	200	10	0.35	0.35	0.67	10	6	200	10	10			21

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

6501130 NATL SEMICOND, (DISCRETE)

28C 35546

T-31-01

PRO ELECTRON SERIES (JFET)



Type No.	Case Style	BV _{GSS} BV _{GDO} (V) @ I _G Min	I _{GSS} I _{DGD} (mA) @ V _{GD} Max	V _P (V) @ V _{DS} Min Max	I _D (mA)	V _{GS} (V) @ V _{GS} Min Max	I _D (μA)	I _{DSS} (mA) @ V _{DS} Min Max	R _g (YFS) (mmho) @ f Min Max	C _{iss} (pF) @ V _{DS} Typ	V _{GS} (V)	C _{iss} (pF) @ V _{GS} Typ	V _{GS} (V)	V _{GS} (V)	V _{GS} (V)	NF (dB) @ R _G = 1k f e _n * Max Typ	Process No.	Pkg. No.	
BF244A	TO-92	30	1	.5	8	15	10	2	6.5	15	3	6.5	.001	4	20	-1	1.1	20	-1
BF244B	TO-92	30	1	.5	8	15	10	6	15	15	3	6.5	.001	4	20	-1	1.1	20	-1
BF244C	TO-92	30	1	.5	8	15	10	12	25	15	3	6.5	.001	4	20	-1	1.1	20	-1
BF245A	TO-92	30	1	.5	8	15	10	2	6.5	15	3	6.5	.001	4	20	-1	1.1	20	-1
BF245B	TO-92	30	1	.5	8	15	10	6	15	15	3	6.5	.001	4	20	-1	1.1	20	-1
BF245C	TO-92	30	1	.5	8	15	10	12	25	15	3	6.5	.001	4	20	-1	1.1	20	-1
BF246A	TO-92	25	1	.6	14.5	15	10	30	80	15	8	.001	11	15	0	3.5	15	0	
BF246B	TO-92	25	1	.6	14.5	15	10	60	140	15	8	.001	11	15	0	3.5	15	0	
BF246C	TO-92	25	1	.6	14.5	15	10	110	250	15	8	.001	11	15	0	3.5	15	0	
BF247A	TO-92	25	1	.6	14.5	15	10	30	80	15	8	.001	11	15	0	3.5	15	0	
BF247B	TO-92	25	1	.6	14.5	15	10	60	140	15	8	.001	11	15	0	3.5	15	0	
BF247C	TO-92	25	1	.6	14.5	15	10	110	250	15	8	.001	11	15	0	3.5	15	0	
BF256A	TO-92	30	1	.5	20	15	10	3	7	15	4.5	.001	.7	20	-1	7.5	800	50	
BF256B	TO-92	30	1	.5	20	15	10	6	13	15	4.5	.001	.7	20	-1	7.5	800	50	
BF256C	TO-92	30	1	.5	20	15	10	11	18	15	4.5	.001	.7	20	-1	7.5	800	50	
8C264A	TO-92	30	1	.5	15	10	10	2	4.5	15	2.5	.001	4.0	15	-1	40*	10*	50	
8C264B	TO-92	30	1	.5	15	10	10	3.5	6.5	15	3.0	.001	4.0	15	-1	40*	10*	50	
8C264C	TO-92	30	1	.5	15	10	10	5.0	8.0	15	3.5	.001	4.0	15	-1	40*	10*	50	
8C264D	TO-92	30	1	.5	15	10	10	7.0	12.0	15	4.0	.001	4.0	15	-1	40*	10*	50	

Pro Electron Series

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